



Progress of 2-µm Detectors for Application to Lidar Remote Sensing

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Outline

- Overview
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- Applications
- Detector Characterization at Langley
- Custom-Designed Detector Validation
- Summary



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Overview

- \cdot Detector with high gain and low noise is a detector of choice for laser remote sensing applications and no commercial detector was available at 2- μm wavelength range.
- NASA Langley Research Center's detector group worked in collaboration with Astro-Power, Inc./University of Delaware to develop custom-designed 2-micron phototransistors using Liquid Phase Epitaxy (LPE) technique.
- These phototransistors have very high gain, but also have longer recovery time, which may cause problem for CO₂ DIAL applications.
- Raytheon achieved high gain, high speed, and ultra low excess noise factor around 1 from the Avalanche Photodiode.
- Therefore, NASA Langley acquired HgCdTe avalanche photodiodes (APD) from Raytheon, characterized and applied in atmospheric testing at $2-\mu m$.



Develop, test, and implement new technology 2 μm detectors for application to laser remote sensing from ground, aircraft, and space.



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$2-\mu m$ Detector Applications

- Detectors with responsivity at broad wavelengths are needed to span a wide wavelength range for the following applications
 - \bullet CO₂, O₃, H₂O, and CH₄
 - aerosols and clouds
 - * detection of a large number of species in the visible-near infrared using active and passive remote sensing techniques, and
 - * enable new science and lower-cost missions through compact instruments



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$2-\mu m$ Detectors Development and Characterization

Single element custom-designed phototransistors and avalanche photodiodes have been developed at Astropower/University of Delaware and Raytheon Vision Systems; and characterized them at NASA Langley Research Center

Measured the phototransistor's responsivity and noise

- Determined device performances, such as detectivity and noise equivalent power
- Demonstrated high responsivity 2650 A/W corresponding to an internal gain of 2737
- High detectivity (D*) 3.9x10¹¹ cm.Hz^{1/2}/W that is equivalent to a noise equivalent power of 4.6x10⁻¹⁴ W/Hz^{1/2}.

Evaluated the APD's spectral response

> Determined high quantum efficiency and high gain



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Detector Calibration





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Custom-Designed Detector Calibration

 $2\ \mu\text{m}$ InGaAsSb Phototransistor Characteristics

Custom-designed 2 µm Detector Technology



- 20 nm Spectral Resolution
- -20 to 20 °C Temperature
- Different Bias Voltages
- Calculated Quantum Efficiency for 0 V at 20 °C



T.F. Refaat, M.N. Abedin, O.V. Sulima, S. Ismail, and U.N. Singh, "AlGaAsSb/InGaAsSb Phototransistors for 2-µm Remote Sensing Applications", *Optical Engineering*, Vol. 43(7), 1647-1650, 2004.



Custom-Designed Detector Calibration

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2 μ m InGaAsSb Phototransistor Characteristics Custom-designed 2 μ m Detector Technology

* InGaAsSb detector peak positions shifted due to temperature variation



M.N. Abedin, T.F. Refaat, O.V. Sulima, and U.N. Singh, "Recent development of Sb-based phototransistors in the 0.9- to 2.2-µm wavelength range for applications to laser remote sensing", **International Journal of High Speed Electronics and Systems**, v.15, No.2, pp. 567-582, (2006).



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Detector Performance Comparison

Existing and Custom-Designed Phototransistor Characteristics

Detectivity (D*)

 With suitable bias voltage and 2-micron radiation, InGaAsSb Phototransistor has the best detectivity, compared to InGaAs (I & II) and HgCdTe (III) technologies.



O.V. Sulima, T.F. Refaat, M.G. Mauk, J.A. Cox, J. Li, S.K. Lohokare, M.N. Abedin, U.N. Singh, and J.A. Rand, "AlGaAsSb/InGaAsSb phototransistors for spectral range around 2-μm", **Electronics Letters**, Vol 40, 766-767, 2004.



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Detector Performance Comparison

Existing and Custom-Designed Phototransistor Characteristics

Noise-Equivalent-Power (NEP)

 With suitable bias voltage, InGaAsSb Phototransistor has the lowest NEP, compared to InGaAs (G5852: 2.3-cutoff) and InGaAs (G5853: 2.6-cutoff) technologies.



M.N. Abedin, T.F. Refaat, O.V. Sulima, and U.N. Singh, "AlGaAsSb/InGaAsSb heterojunction phototransistor with high optical gain and wide dynamic range", IEEE Trans. Electron Devices, Vol. 51(12), pp 2013 - 2018 (2004).



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Detector Performance Comparison

Determination of Custom-designed 2 μ m Phototransistor's Gain

* InGaAsSb phototransistor gain variation at different bias voltage for fixed incident radiation @2.0 μ m

Gain

- Different Temperature.
- Bias Voltages (0.0- to 5.8-volts).





2 µm Avalanche Photodiode Performance

- QE at Room and Cryogenic Temperatures with O V Bias Voltage
- Gain at Room and Cryogenic Temperatures with different Bias Voltages

Quantum Efficiency

Gain



Note: APD was not AR coated, QE will exceed >80% with AR coating



2 µm Avalanche Photodiode Performance

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Summary Table of the 2 μm APD

Detector Parameters	NASA APD requirements	Achieved results at LaRC
Detector Type	Avalanche Photodiode	Avalanche Photodiode
Detector Material	HgCdTe	HgCdTe
Spectral Range	1.0 - 2.4 mic <i>r</i> on	1.0 - 2.6 mic <i>r</i> on
Detector Diameter	200-micron	200-micron
Quantum Efficiency	> 70% @ 2.05 micron	65% @ Room Temp 58% @ Cryogenic Temp.
NEP	< 2×10=14 W/sqrt (Hz)	
Multiplication Gain	50	9 @ 15.0 V @ Room Temp 21 @ 13.4 V @Cryogenic
Excess Noise Factor	× 2.0	
Detector plus Amplifier Bandwidth	5 MHz	

Note: APD was not AR coated, QE will exceed >80% with AR coating; NEP, excess noise factor, and bandwidth are not evaluated



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Custom-Designed Detector Validation

Validated phototransistors at National Center for Atmospheric Research (NCAR), Boulder, Colorado, by integrating them into Lidar System operating at $1.543-\mu m$ and also at NASA Langley Research Center operating at $2.0-\mu m$

Results:

- Phototransistor was optimized for $2-\mu m$ detection, but its performance is nearly similar to the InGaAs APD at $1.5-\mu m$.
- \cdot Lidar tests were performed at 2.0- μm wavelength and results are promising



Spectral Response & Quantum Efficiency of Phototransistor

- \bullet NCAR Lidar operates at 1.5 μm wavelength.
- LaRC Lidar operates at 2.0 µm wavelength
- Lidar serves as a useful test-bed for comparing the phototransistor profile with that of the InGaAs APD
- This comparison validates the application of the phototransistor for lidar instruments





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Phototransistor Validation Setup at NCAR



Courtesy: Schematic of the Lidar detection system at NCAR, Boulder, Colorado, with the phototransistor installed into the receiver's perpendicular polarization channel. Transmitter: 170mJ/pulse 4 ns pulse width Receiver: 40 cm Newtonian Telescope

- Obtained lidar backscatter signals through the phototransistor and the InGaAs APD simultaneously
- Splitted backscatter signal into two equivalently energetic beams and focused them onto two independent detectors



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Atmospheric Return at 1.5-µm

- Color image of the far-field temporal variation of the return signals
- Monitoring an optically thin cloud between 4.6 and 5.8 km altitude

<u>16:00-16:25;</u> The HPT operating at 20°C with 155 mJ/pulse laser energy.

<u>16:30-16:45;</u> Temperature =10°C.

<u>16:50-17:00;</u> Temperature = 30°C.

<u>17:10-17:19</u>; Laser energy reduced to 50% applying a neutral density filter to the transmitted beam (20°C).





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Return Signals from Targets

Acquired return signals from clouds using $2-\mu m$ wavelength



Returns signals recorded at different times. (a) Thin clouds located at about 3.5 km and 8.5 km and (b) Thin cloud located at about 3.5 km



Atmospheric Return at 2-

- Atmospheric images were obtained using phototransistor at 2-micron
- The system was pointed at thin discrete clouds at about 3.5–8.5 km altitudes

- The color image from two layers of clouds and boundary-layer
- The time scale spans between 0 to 550 sec, which corresponds to the phototransistor operating time at a temperature of 20 °C.



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Note: APD was not optimized for acquiring maximum signal, preliminary results show that APD has good sensitivity without optimization



Summary

- Custom-designed phototransistors have been developed at Astropower/UD and characterized at NASA Langley Research Center under LRRP.
- \cdot Phototransistor shows comparable performance with respect to InGaAs APD operating at 1.5 μm wavelength under lidar testing
- Results indicated an acceptable performance of the phototransistor device, in terms of detecting 5 km range atmospheric structures.
- \cdot Evaluated the phototransistor's performances at 2.0- μ m wavelength
- > Measurements included detecting atmospheric structure consisting of thin clouds in the mid-altitude and near-field boundary layer.
- Preliminary results indicate that HgCdTe APD has some sensitivity with respect to phototransistor operating at $2.0-\mu m$ wavelength.



Acknowledgment

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